

Notice of References Cited	Application/Control No. 10/665,083	Applicant(s)/Patent Under Reexamination WONG, MARVIN GLENN	
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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2004/0038616	02-2004	Toyoda et al.	445/24
	B	US-			
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*	U	Wilson, B.A., Case, E.D., "In situ microscopy of crack healing in borosilicate glass", Journal of Materials Science 32 (1997) 3163-3175
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*	W	Denry, I.L., Holloway, J.A., Tarr, L.A., "effect of heat treatment on microcrack healing behavior of a machinable dental ceramic", Journal of biomedical materials research(Applied Biomaterials) 48: 791-796, 1999
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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